

# 20V N-Channel Trench MOSFET(Preliminary)

## **General Description**

- Trench Power technology
- Low R<sub>DS(ON)</sub>
- Low Gate Charge
- Optimized for fast-switching applications

### **Applications**

- Synchronous Rectification in DC/DC and AC/DC Converters
- Isolated DC/DC Converters in Telecom and Industrial

#### **Product Summary**

 $V_{DS}$  20V  $I_{D}$  (at  $V_{GS} = 10V$ ) 130A

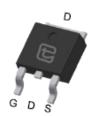
 $R_{DS(ON)}$  (at  $V_{GS}$ =10V) < 3.1m $\Omega$ 

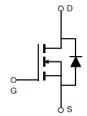
$$\begin{split} R_{DS(ON)} & \text{ (at V}_{GS} \!=\! 4.5 \text{V)} & < 3.3 \text{m} \Omega \\ R_{DS(ON)} & \text{ (at V}_{GS} \!=\! 2.5 \text{V)} & < 4.8 \text{m} \Omega \end{split}$$

100% UIS Tested



TO-252





Part Number	Package Type	Form	Marking
TTD130N02GT	TO-252	Tape&Reel	130N02GT

## Absolute Maximum Ratings (T<sub>A</sub> =25°C unless otherwise noted)

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V <sub>DS</sub>	20	V
Gate-Source Voltage		$V_{GS}$	±20	V
Continuous Drain Current B	T <sub>C</sub> =25°C	- I <sub>D</sub>	46	Δ.
	T <sub>C</sub> =100°C		46	А
Pulsed Drain Current <sup>A</sup>		I <sub>DM</sub>	390	А
Avalanche Current <sup>A</sup> Single Pulse Avalanche Energy L =0.3mH <sup>A</sup>		I <sub>AS</sub>	30	А
		E <sub>AS</sub>	135	mJ
Dawer Dissipation C	T <sub>C</sub> =25°C	P <sub>D</sub>	120	W
ower Dissipation <sup>C</sup>	T <sub>C</sub> =100°C		60	W
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	°C

#### Thermal Characteristics

Parameter		Symbol	Maximum	Units	
Maximum Junction-to-Case	Steady-State	$R_{\Theta JC}$	1.25	00.004	
Maximum Junction-to-Ambient	Steady-State	$R_{\Theta JA}$	100	°C/W	



Comple ed	Bernarter	Conditions		Value			
Symbol	Parameter			Min	Тур	Max	Units
STATIC P	ARAMETERS					_	
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		20			V
	Zero Gate Voltage Drain Current	V <sub>DS</sub> =20V, V <sub>GS</sub> =0V	T <sub>J</sub> =25°C			1	μΑ
I <sub>DSS</sub>			T <sub>J</sub> =100°C			25	
I <sub>GSS</sub>	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	•			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		0.5	0.7	1.2	V
		V <sub>GS</sub> =10V, I <sub>D</sub> =30A			2.4	3.1	mΩ
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =4.5V, I <sub>D</sub> =30A			2.6	3.3	mΩ
		V <sub>GS</sub> =2.5V, I <sub>D</sub> =30A			3.7	4.8	mΩ
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =10V, I <sub>D</sub> =20A			17		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =46A, V <sub>GS</sub> =0V				1	V
I <sub>s</sub>	Maximum Body-Diode Continuous Curre	ent <sup>B</sup>				46	Α
DYNAMIC	PARAMETERS						
C <sub>iss</sub>	Input Capacitance	$V_{GS} = 0V, V_{DS} = 10V, f = 1MH_Z$			5291		
C <sub>oss</sub>	Output Capacitance				1254		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				946		
SWITCHIN	NG PARAMETERS						
Q <sub>g</sub> (10V)	Total Gate Charge				130		
$Q_{gs}$	Gate Source Charge	$V_{GS} = 10V, V_{DS} = 10V, I_{D} = 50A$			7		nC
$Q_{gd}$	Gate Drain Charge				24		
t <sub>D(on)</sub>	Turn-On Delay Time	$V_{GS} = 10V, V_{DS} = 10V, I_{D} = 50A,$ $R_{G} = 3\Omega$			13		
t <sub>r</sub>	Turn-On Rise Time				12		ns
$T_{D(off)}$	Turn-Off Delay Time				43		
t <sub>f</sub>	Turn-Off Fall Time				20		
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I FOA d:/d+ 4004/			21		ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =50A, di/dt =100A/μs			20		nC

- A. Single pulse width limited by maximum junction temperature.
- B. The maximum current rating is package limited.
- C. The power dissipation  $P_D$  is based on  $T_{J(MAX)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

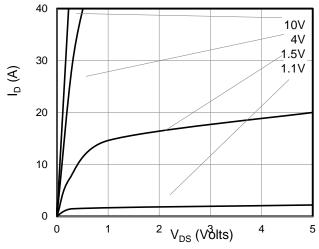
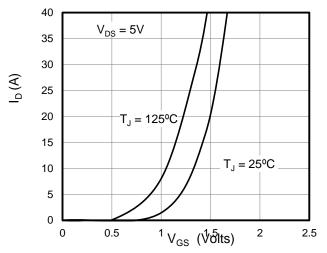


Figure 1: On-Region Characteristics



**Figure 2: Transfer Characteristics** 

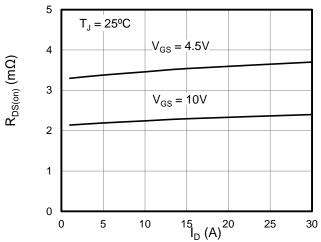
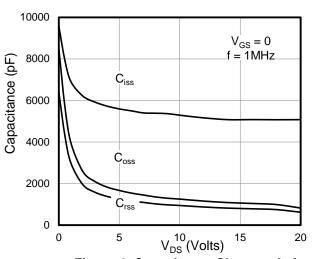


Figure 3: On-Resistance vs. Drain Current



**Figure 4: Capacitance Characteristics** 

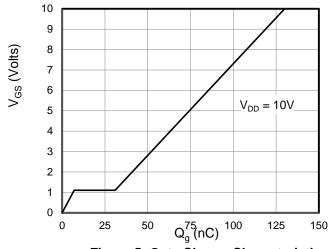


Figure 5: Gate Charge Characteristics

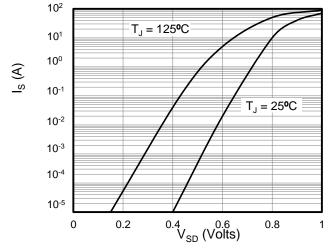


Figure 6: Body Diode Forward Voltage

 $Z_{\theta, JC}$  Normalized Transient Thermal Resistance

Wuxi Unigroup Microelectronics CO.,LTD.

#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

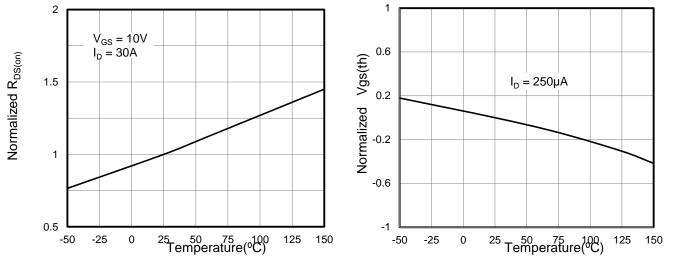


Figure 7: On-Resistance vs. Junction Temperature

Figure 8: Vgs(th) vs. Junction Temperature

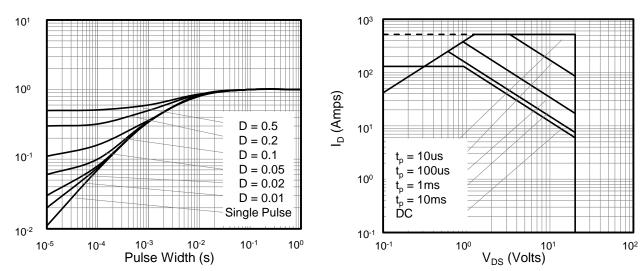


Figure 11: Normalized Transient Thermal Resistance

Figure 12: Safe Operating Area

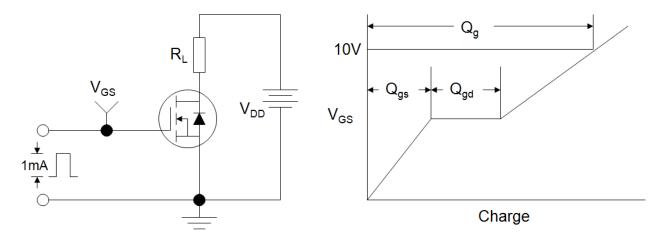


Figure A: Gate Charge Test Circuit and Waveforms

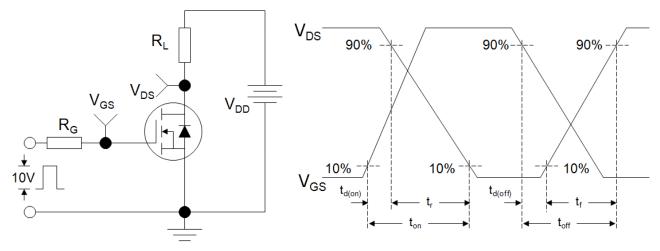


Figure B: Resistive Switching Test Circuit and Waveforms

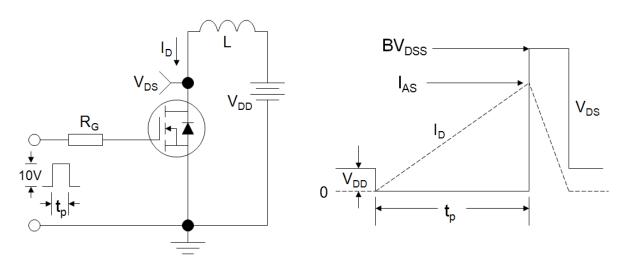
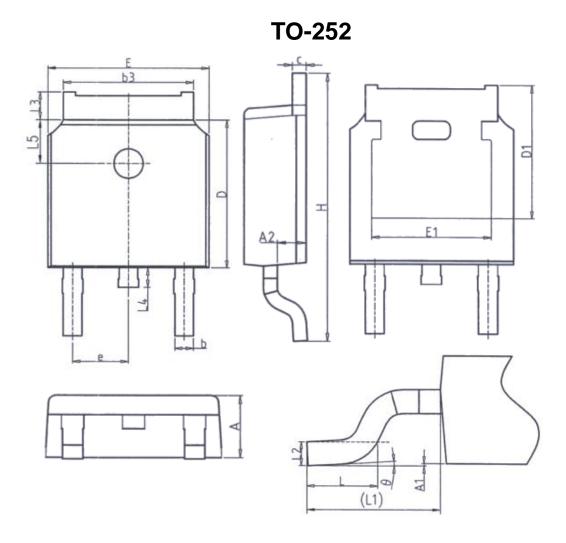


Figure C: Unclamped Inductive Switching (UIS) Test Circuit and Waveforms





Unit: mm				
Symbol	Min.	Max.		
Α	2. 20	2. 40		
A1	0.00	0. 20		
A2	0. 97	1. 17		
b	0. 68	0. 90		
b3	5. 20	5. 50		
С	0. 43	0. 63		
D	5. 98	6. 22		
D1	D1 5. 30REF			
E	6. 40	6. 80		
E1	4. 63	_		

Unit: mm			
Symbol	Min.	Max.	
е	e 2. 286BSC		
Н	9. 40	10.50	
L	1. 38	1. 75	
L1	2. 90REF		
L2	0. 51BSC		
L3	0.88	1. 28	
L4	_	1.00	
L5	1. 65	1. 95	
θ	0°	8°	



### **Disclaimer**

All product specifications and data are subject to change without notice.

For documents and material available from this datasheet, Wuxi Unigroup does not warrant or assume any legal liability or responsibility for the accuracy, completeness of any product or technology disclosed hereunder.

No license, express or implied, by estoppels or otherwise, to any intellectual property rights is granted by this document or by any conduct of Wuxi Unigroup.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications. Customers using or selling Wuxi Unigroup products not expressly indicated for use in such applications do so entirely at their own risk and agree to fully indemnify Wuxi Unigroup for any damages arising or resulting from such use or sale.

Wuxi Unigroup disclaims any and all liability arising out of the use or application of any product described herein or of any information provided herein to the maximum extent permitted by law. The product specifications do not expand or otherwise modify Wuxi Unigroup's terms and conditions of purchase, including but not limited to the warranty expressed therein, which apply to these products.

Wuxi Unigroup Microelectronics CO., LTD. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.

In the event that any or all Wuxi Unigroup products (including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.

Information (including circuit diagrams and circuit parameters) herein is for example only. It is not guaranteed for volume production. Wuxi Unigroup believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.